Search I	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/014,323	COLE ET AL.
Examiner	Art Unit
Christine Ng	2616

	SEARCHED		
Class	Subclass	Date	Examiner
370	216	5/22/2006	CN
370	217	5/22/2006	CN
370	218	5/22/2006	CN
370	219	5/22/2006	CN
370	220	5/22/2006	CN
370	221	5/22/2006	CN
370	225	5/22/2006	CN
370	254	5/22/2006	CN
370	255	5/22/2006	CN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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(INCLUDING	SEARCH STRATE	3Y)
	DATE	EXMR
Huy Vu	5/22/2006	6 CN